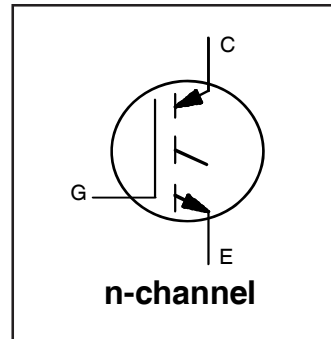


IRG7PSH73K10PbF

INSULATED GATE BIPOLAR TRANSISTOR

Features

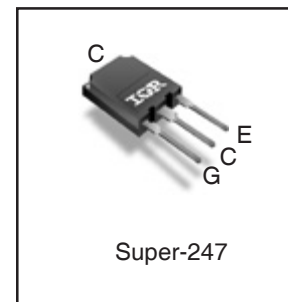
- Low $V_{CE(ON)}$ Trench IGBT Technology
- Low Switching Losses
- Maximum Junction Temperature 175 °C
- 10 μ S short Circuit SOA
- Square RBSOA
- 100% of The Parts Tested for I_{LM}
- Positive $V_{CE(ON)}$ Temperature Coefficient
- Tight Parameter Distribution
- Lead Free Package



$V_{CES} = 1200V$
$I_{C(Nominal)} = 75A$
$t_{SC} \geq 10\mu s, T_{J(max)} = 175^{\circ}C$
$V_{CE(on)} \text{ typ.} = 2.0V$

Benefits

- High Efficiency in a Wide Range of Applications
- Suitable for a Wide Range of Switching Frequencies due to Low $V_{CE(ON)}$ and Low Switching Losses
- Rugged Transient Performance for Increased Reliability
- Excellent Current Sharing in Parallel Operation



G	C	E
Gate	Collector	Emitter

Absolute Maximum Ratings

	Parameter	Max.	Units
V_{CES}	Collector-to-Emitter Voltage	1200	V
$I_C @ T_C = 25^{\circ}C$	Continuous Collector Current	220 [Ⓞ]	A
$I_C @ T_C = 100^{\circ}C$	Continuous Collector Current	130	
$I_{NOMINAL}$	Nominal Current	75	
I_{CM}	Pulse Collector Current, $V_{GE}=15V$	225	
I_{LM}	Clamped Inductive Load Current, $V_{GE}=20V$ [Ⓞ]	300	
V_{GE}	Continuous Gate-to-Emitter Voltage	± 30	V
$P_D @ T_C = 25^{\circ}C$	Maximum Power Dissipation	1150	W
$P_D @ T_C = 100^{\circ}C$	Maximum Power Dissipation	580	
T_J T_{STG}	Operating Junction and Storage Temperature Range	-55 to +175	°C
	Soldering Temperature, for 10 sec.	300 (0.063 in. (1.6mm) from case)	
	Mounting Torque, 6-32 or M3 Screw	10 lbf-in (1.1 N·m)	

Thermal Resistance

	Parameter	Min.	Typ.	Max.	Units
$R_{\theta JC}$ (IGBT)	Thermal Resistance Junction-to-Case-(each IGBT) [Ⓞ]	—	—	0.13	°C/W
$R_{\theta CS}$	Thermal Resistance, Case-to-Sink (flat, greased surface) [Ⓞ]	—	0.24	—	
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient (typical socket mount)	—	40	—	

Electrical Characteristics @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

	Parameter	Min.	Typ.	Max.	Units	Conditions
$V_{(BR)CES}$	Collector-to-Emitter Breakdown Voltage	1200	—	—	V	$V_{GE} = 0V, I_C = 250\mu\text{A}$ ④
$\Delta V_{(BR)CES}/\Delta T_J$	Temperature Coeff. of Breakdown Voltage	—	1.58	—	V/°C	$V_{GE} = 0V, I_C = 5.0\text{mA}$ (25°C-175°C) ④
$V_{CE(on)}$	Collector-to-Emitter Saturation Voltage	—	2.0	2.3	V	$I_C = 75A, V_{GE} = 15V, T_J = 25^\circ\text{C}$ ③
		—	2.50	—		$I_C = 75A, V_{GE} = 15V, T_J = 150^\circ\text{C}$ ③
		—	2.60	—		$I_C = 75A, V_{GE} = 15V, T_J = 175^\circ\text{C}$ ③
$V_{GE(th)}$	Gate Threshold Voltage	5.0	—	7.5	V	$V_{CE} = V_{GE}, I_C = 3.5\text{mA}$
$\Delta V_{GE(th)}/\Delta T_J$	Threshold Voltage temp. coefficient	—	-18	—	mV/°C	$V_{CE} = V_{GE}, I_C = 3.5\text{mA}$ (25°C - 175°C)
g_{fe}	Forward Transconductance	—	53	—	S	$V_{CE} = 50V, I_C = 75A, PW = 80\mu\text{s}$
I_{CES}	Collector-to-Emitter Leakage Current	—	1.0	25	μA	$V_{GE} = 0V, V_{CE} = 1200V, T_J = 25^\circ\text{C}$
		—	2340	—		$V_{GE} = 0V, V_{CE} = 1200V, T_J = 175^\circ\text{C}$
I_{GES}	Gate-to-Emitter Leakage Current	—	—	± 400	nA	$V_{GE} = \pm 30V$

Switching Characteristics @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

	Parameter	Min.	Typ.	Max.	Units	Conditions
Q_g	Total Gate Charge (turn-on)	—	360	540	nC	$I_C = 75A$ ③ $V_{GE} = 15V$ $V_{CC} = 600V$
Q_{ge}	Gate-to-Emitter Charge (turn-on)	—	87	130		
Q_{gc}	Gate-to-Collector Charge (turn-on)	—	180	270		
E_{on}	Turn-On Switching Loss	—	7.7	8.7	mJ	$I_C = 75A, V_{CC} = 600V, V_{GE} = 15V$ ③ $R_G = 4.7\Omega, L = 200\mu\text{H}, T_J = 25^\circ\text{C}$ Energy losses include tail & diode reverse recovery
E_{off}	Turn-Off Switching Loss	—	4.6	5.6		
E_{total}	Total Switching Loss	—	12.3	14.3		
$t_{d(on)}$	Turn-On delay time	—	63	81	ns	$I_C = 75A, V_{CC} = 600V, V_{GE} = 15V$ ③ $R_G = 4.7\Omega, L = 200\mu\text{H}, T_J = 25^\circ\text{C}$
t_r	Rise time	—	118	138		
$t_{d(off)}$	Turn-Off delay time	—	267	291		
t_f	Fall time	—	114	134		
E_{on}	Turn-On Switching Loss	—	11	—	mJ	$I_C = 75A, V_{CC} = 600V, V_{GE} = 15V$ ③ $R_G = 4.7\Omega, L = 200\mu\text{H}, T_J = 175^\circ\text{C}$ Energy losses include tail & diode reverse recovery
E_{off}	Turn-Off Switching Loss	—	7.4	—		
E_{total}	Total Switching Loss	—	18.4	—		
$t_{d(on)}$	Turn-On delay time	—	62	—	ns	$I_C = 75A, V_{CC} = 600V, V_{GE} = 15V$ ③ $R_G = 4.7\Omega, L = 200\mu\text{H}$ $T_J = 175^\circ\text{C}$
t_r	Rise time	—	110	—		
$t_{d(off)}$	Turn-Off delay time	—	330	—		
t_f	Fall time	—	237	—		
C_{ies}	Input Capacitance	—	9450	—	pF	$V_{GE} = 0V$ $V_{CC} = 30V$ $f = 1.0\text{MHz}$
C_{oes}	Output Capacitance	—	340	—		
C_{res}	Reverse Transfer Capacitance	—	230	—		
RBSOA	Reverse Bias Safe Operating Area	FULL SQUARE				$I_C = 300A$ $V_{CC} = 960V, V_p = 1200V$ $R_G = 4.7\Omega, V_{GE} = +20V \text{ to } 0V, T_J = 175^\circ\text{C}$
SCSOA	Short Circuit Safe Operating Area	10	—	—	μs	$V_{CC} = 600V, V_p = 1200V, T_J = 150^\circ\text{C}$ $R_G = 4.7\Omega, V_{GE} = +15V \text{ to } 0V$

Notes:

- ① Calculated continuous current based on maximum allowable junction temperature. Bond wire current limit is 195A. Note that current limitations arising from heating of the device leads may occur with some lead mounting arrangements. (Refer to AN-1140)
- ② $V_{CC} = 80\% (V_{CES}), V_{GE} = 20V, L = 20\mu\text{H}, R_G = 5.0\Omega$.
- ③ Pulse width $\leq 400\mu\text{s}$; duty cycle $\leq 2\%$.
- ④ Refer to AN-1086 for guidelines for measuring $V_{(BR)CES}$ safely.
- ⑤ R_θ is measured at T_J of approximately 90°C .

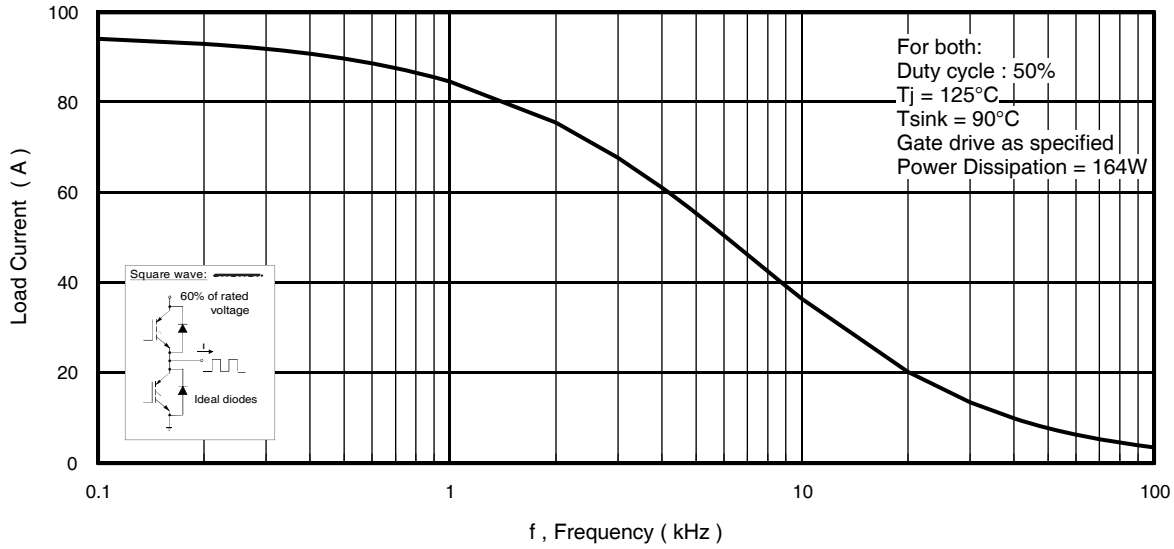


Fig. 1 - Typical Load Current vs. Frequency

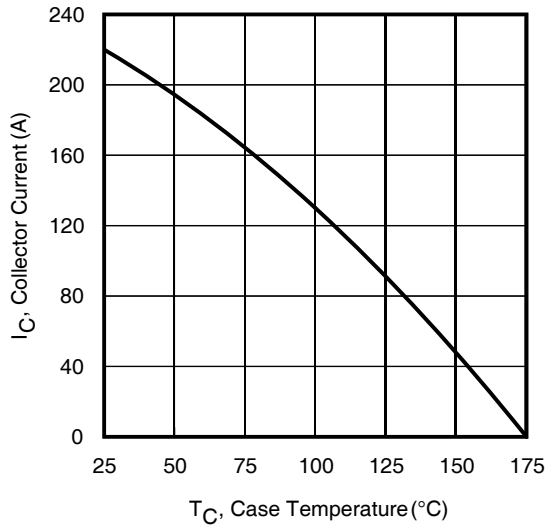


Fig. 2 - Maximum DC Collector Current vs. Case Temperature

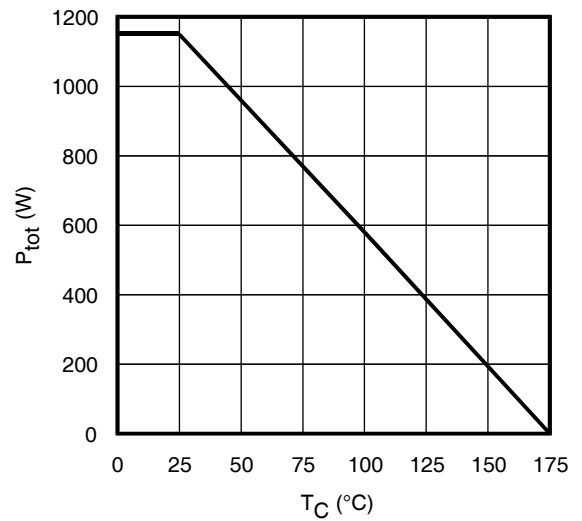


Fig. 3 - Power Dissipation vs. Case Temperature

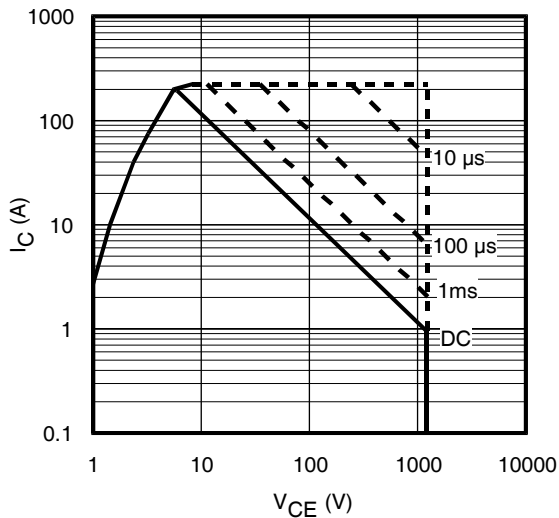


Fig. 4 - Forward SOA
 $T_C = 25^\circ\text{C}$, $T_J \leq 175^\circ\text{C}$; $V_{GE} = 15\text{V}$

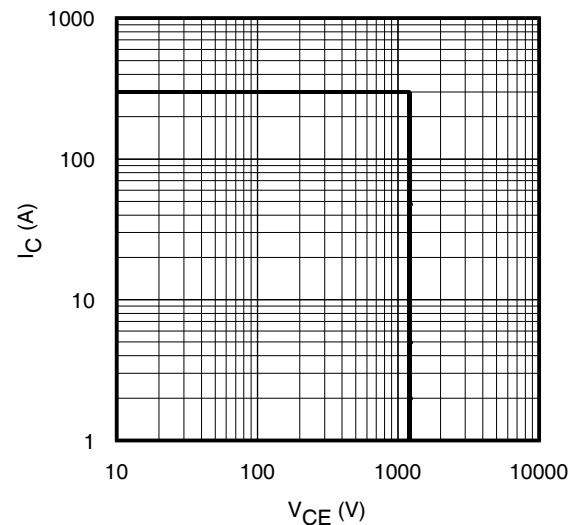


Fig. 5 - Reverse Bias SOA
 $T_J = 175^\circ\text{C}$; $V_{GE} = 20\text{V}$

IRG7PSH73K10PbF

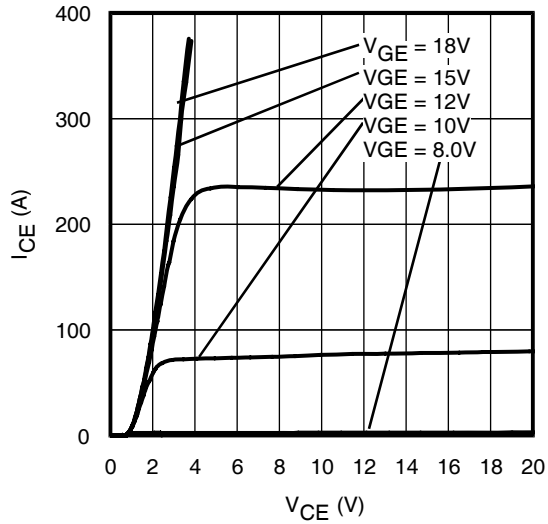


Fig. 6 - Typ. IGBT Output Characteristics
 $T_J = -40^\circ\text{C}$; $t_p = 80\mu\text{s}$

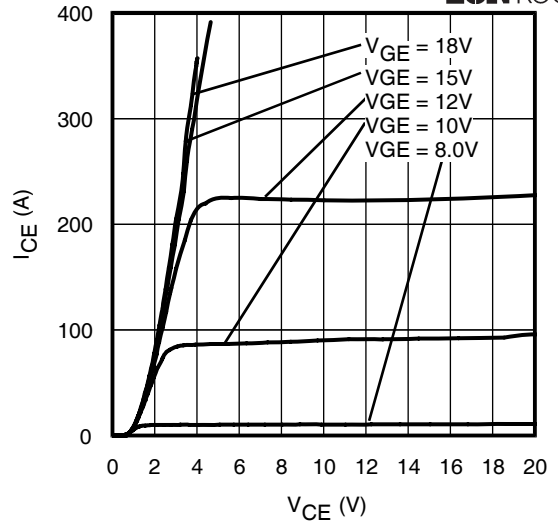


Fig. 7 - Typ. IGBT Output Characteristics
 $T_J = 25^\circ\text{C}$; $t_p = 80\mu\text{s}$

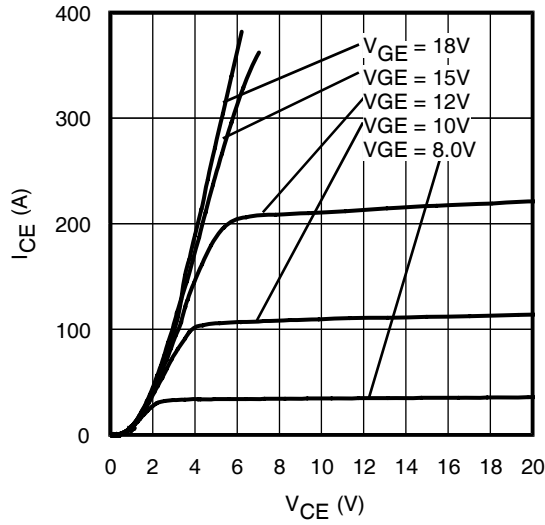


Fig. 8 - Typ. IGBT Output Characteristics
 $T_J = 175^\circ\text{C}$; $t_p = 80\mu\text{s}$

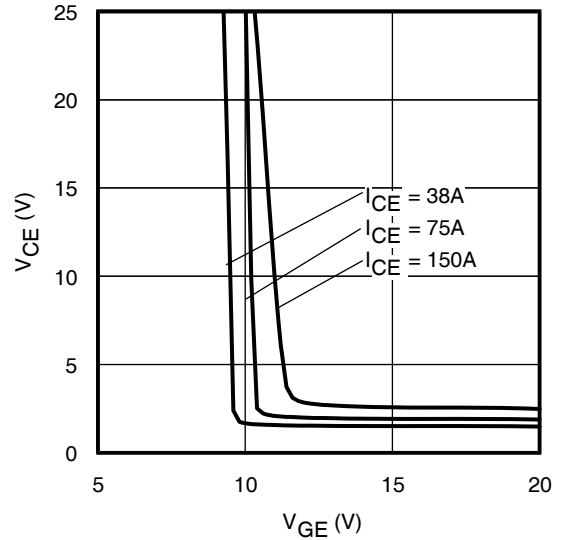


Fig. 9 - Typical V_{CE} vs. V_{GE}
 $T_J = -40^\circ\text{C}$

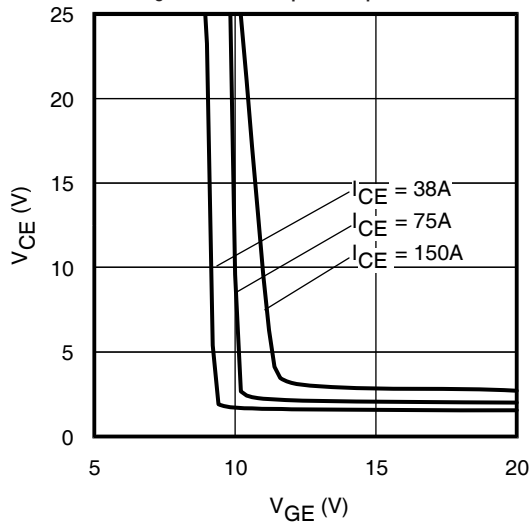


Fig. 10 - Typical V_{CE} vs. V_{GE}
 $T_J = 25^\circ\text{C}$

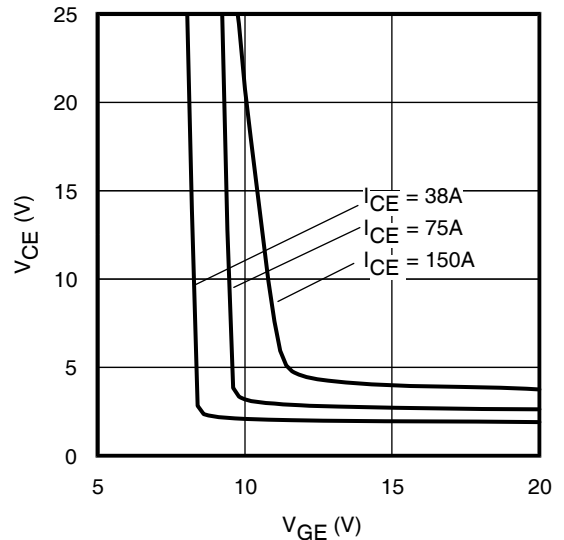


Fig. 11 - Typical V_{CE} vs. V_{GE}
 $T_J = 175^\circ\text{C}$

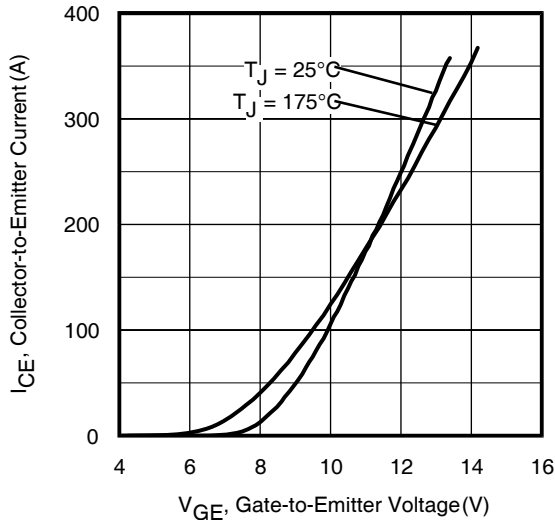


Fig. 12- Typ. Transfer Characteristics
 $V_{CE} = 50V$; $t_p = 10\mu s$

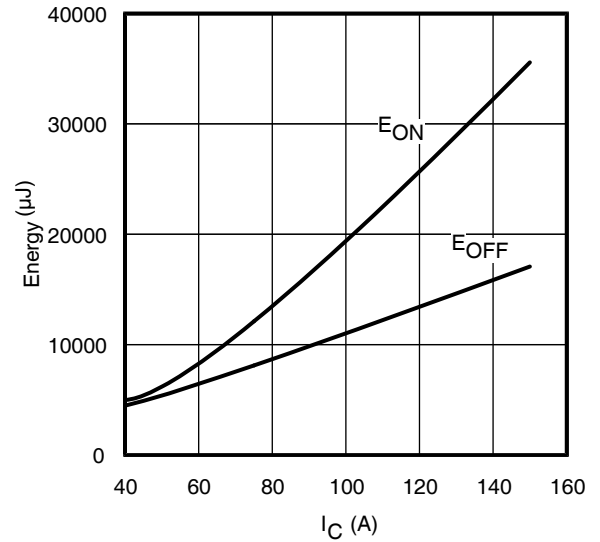


Fig. 13 - Typ. Energy Loss vs. I_C
 $T_J = 175^\circ C$; $L = 200\mu H$; $V_{CE} = 600V$, $R_G = 5.0\Omega$; $V_{GE} = 15V$

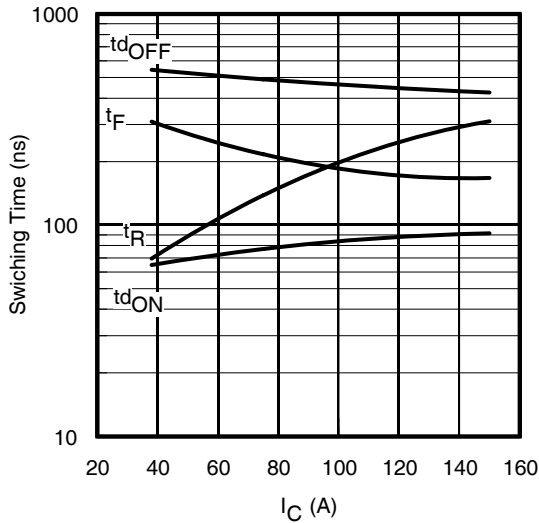


Fig. 14 - Typ. Switching Time vs. I_C
 $T_J = 175^\circ C$; $L = 200\mu H$; $V_{CE} = 600V$, $R_G = 5.0\Omega$; $V_{GE} = 15V$

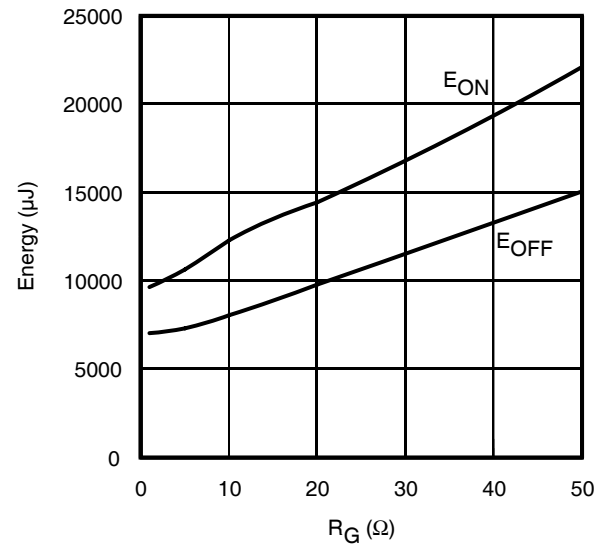


Fig. 15 - Typ. Energy Loss vs. R_G
 $T_J = 175^\circ C$; $L = 200\mu H$; $V_{CE} = 600V$, $I_{CE} = 75A$; $V_{GE} = 15V$

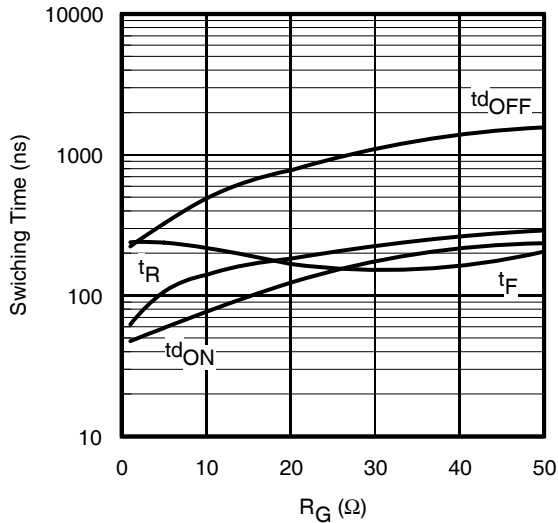


Fig. 16 - Typ. Switching Time vs. R_G
 $T_J = 175^\circ C$; $L = 200\mu H$; $V_{CE} = 600V$, $I_{CE} = 75A$; $V_{GE} = 15V$

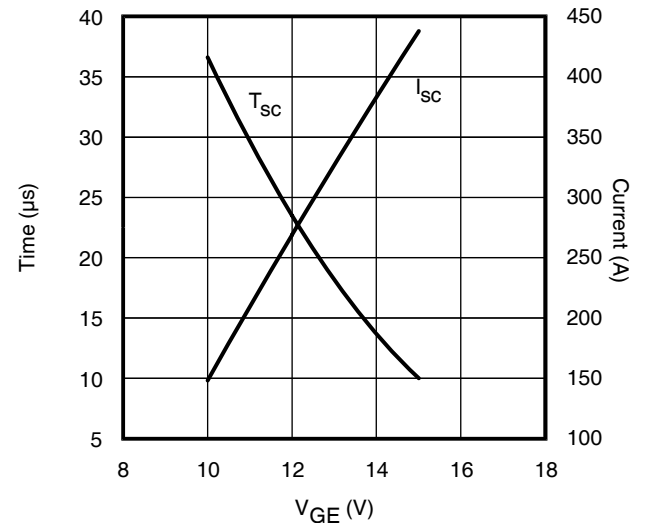


Fig. 17 - V_{GE} vs. Short Circuit Time
 $V_{CC} = 600V$; $T_C = 150^\circ C$

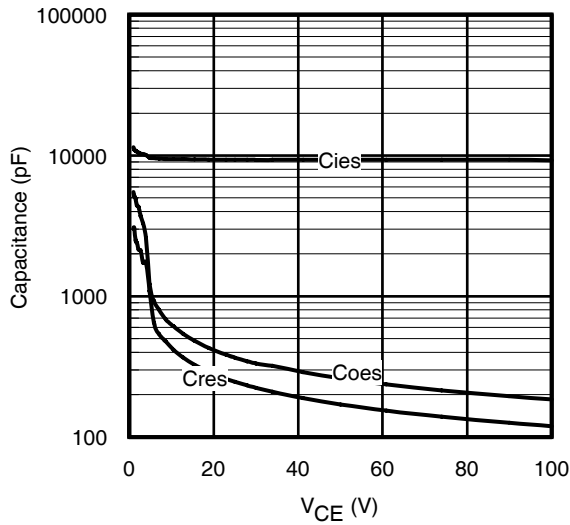


Fig. 18 - Typ. Capacitance vs. V_{CE}
 $V_{GE} = 0V$; $f = 1MHz$

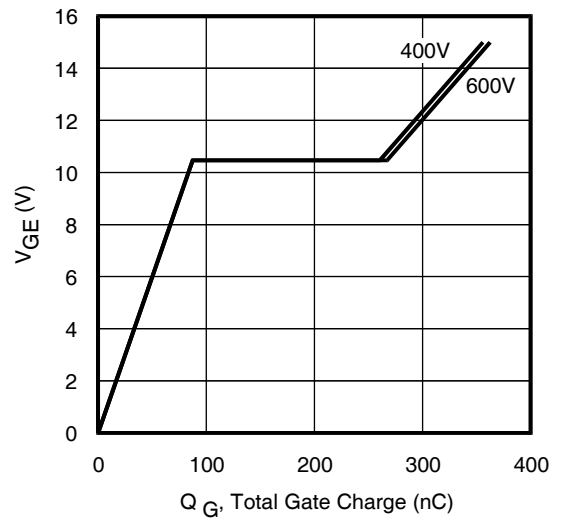


Fig. 19- Typical Gate Charge vs. V_{GE}
 $I_{CE} = 75A$; $L = 330\mu H$

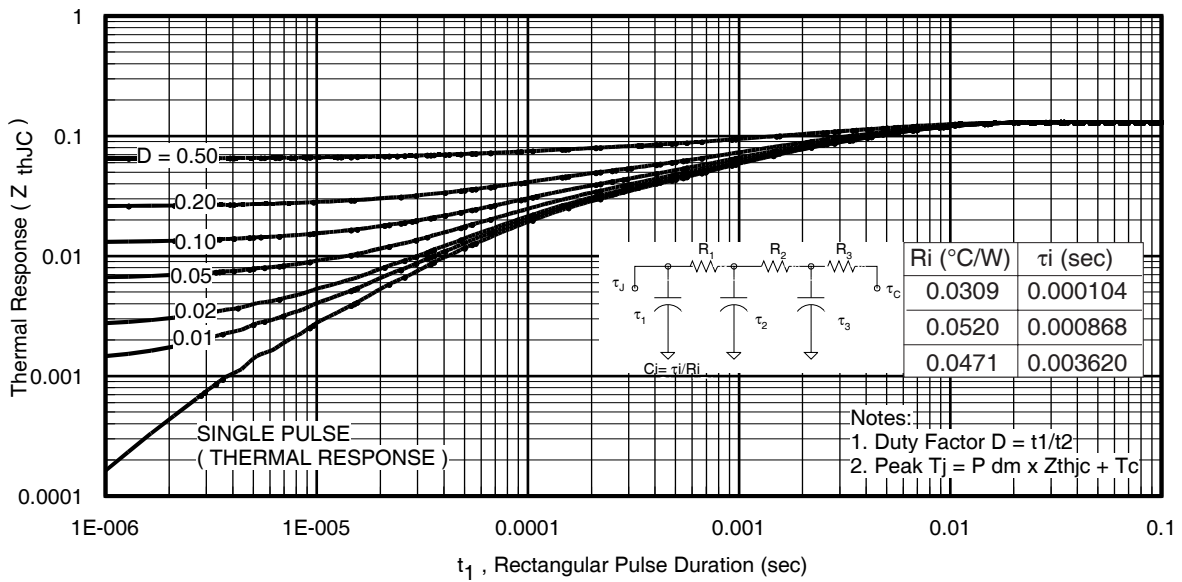


Fig 20. Maximum Transient Thermal Impedance, Junction-to-Case

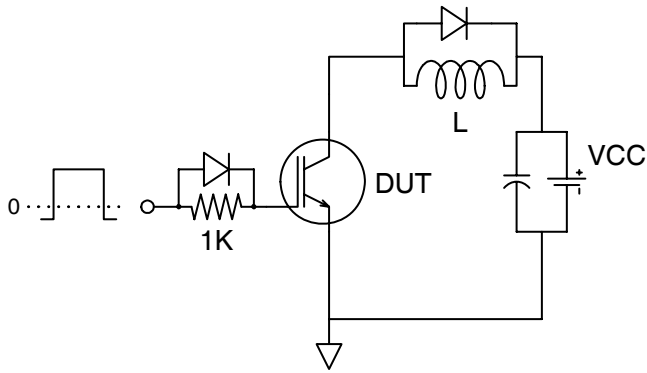


Fig.C.T.1 - Gate Charge Circuit (turn-off)

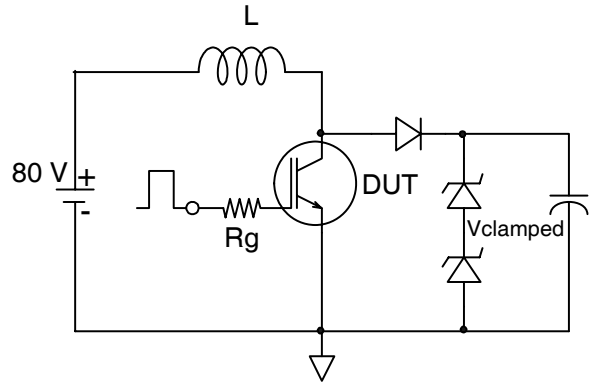


Fig.C.T.2 - RBSOA Circuit

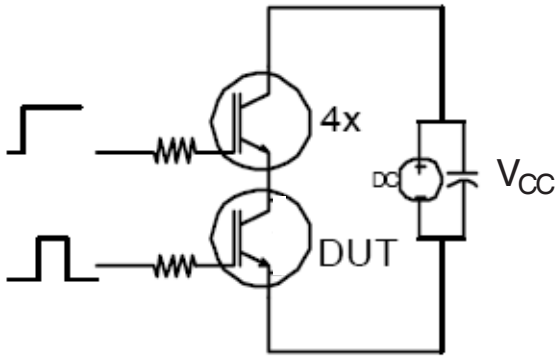


Fig.C.T.3 - S.C. SOA Circuit

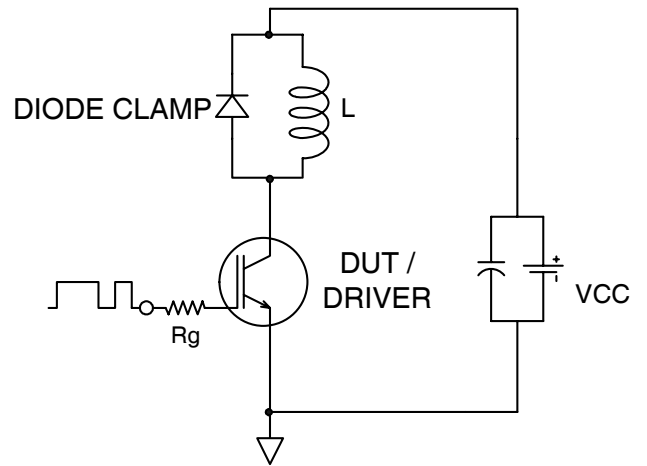


Fig.C.T.4 - Switching Loss Circuit

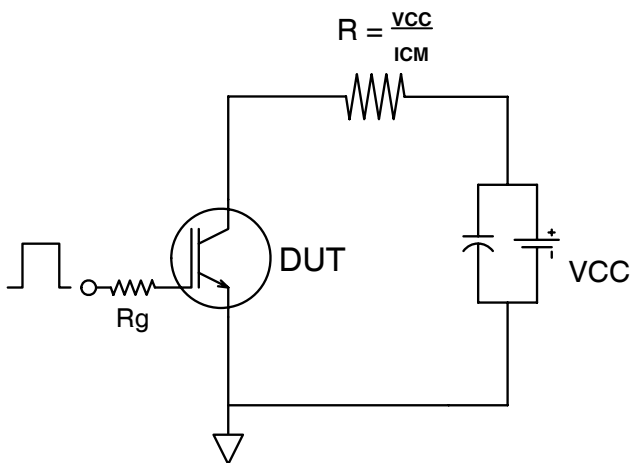


Fig.C.T.5 - Resistive Load Circuit

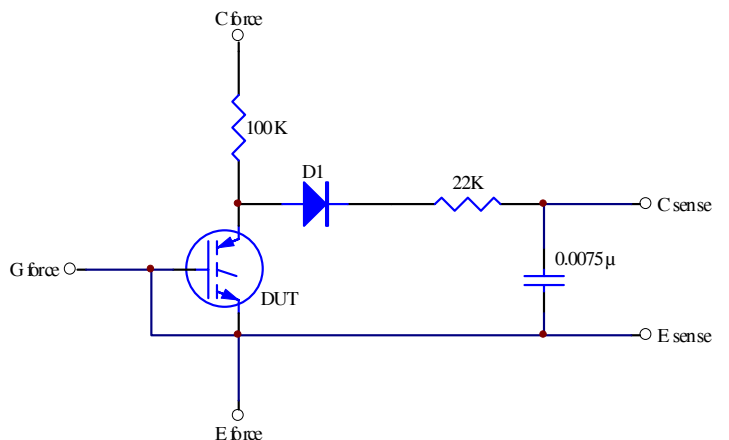


Fig.C.T.6 - BVCES Filter Circuit

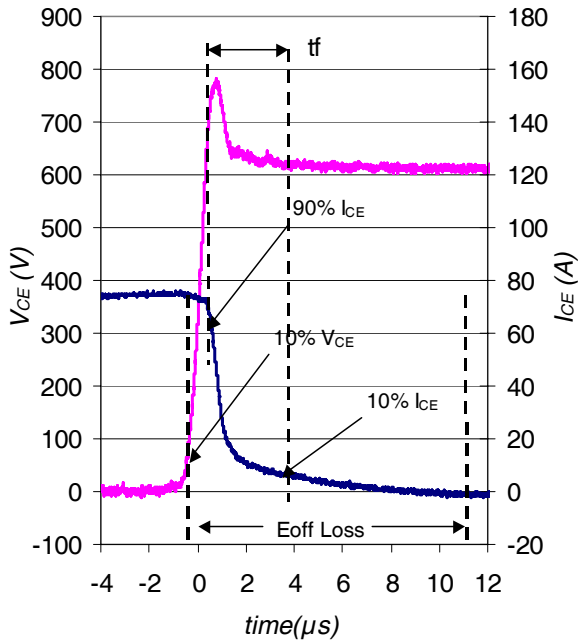


Fig. WF1 - Typ. Turn-off Loss Waveform
@ $T_J = 175^\circ\text{C}$ using Fig. CT.4

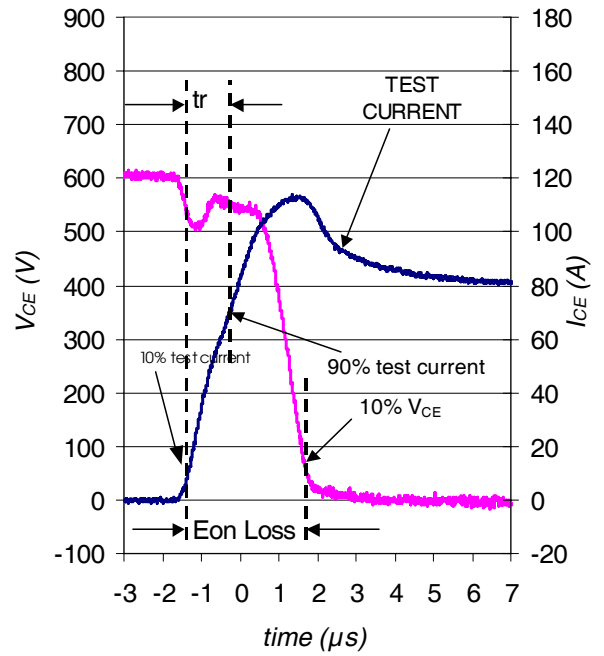


Fig. WF2 - Typ. Turn-on Loss Waveform
@ $T_J = 175^\circ\text{C}$ using Fig. CT.4

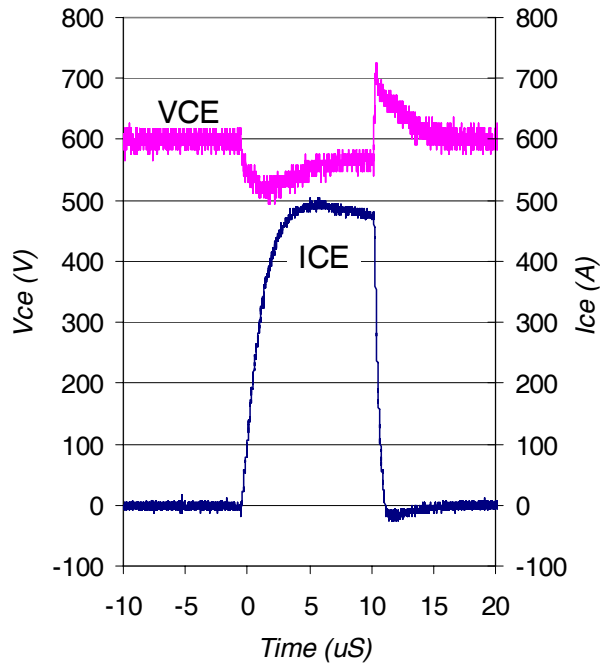
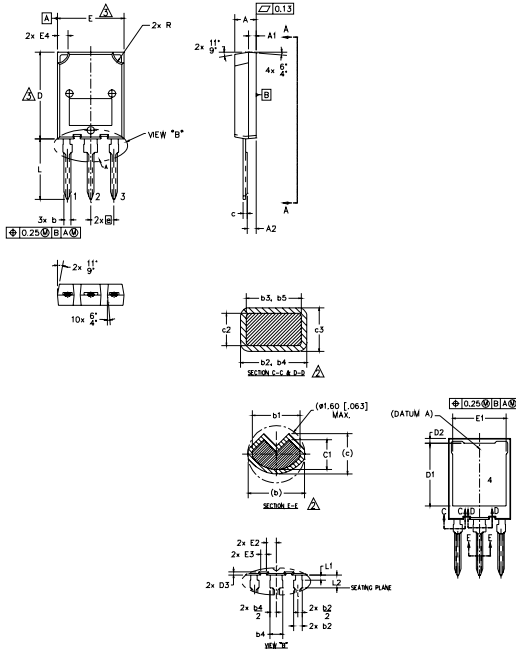


Fig. WF3 - Typ. S.C. Waveform
@ $T_J = 150^\circ\text{C}$ using Fig. CT.3

Case Outline and Dimensions — Super-247



NOTES:
1. DIMENSIONING AND TOLERANCING AS PER ASME Y14.5M-1994
2. DIMENSIONS b1, b3, b5, c1 & c3 APPLY TO BASE METAL ONLY.
3. DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED 0.127 [0.005] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTER EXTREMES OF THE PLASTIC BODY.
4. ALL DIMENSIONS SHOWN IN MILLIMETERS.
5. CONTROLLING DIMENSION: MILLIMETER.
6. OUTLINE CONFORMS TO JEDEC OUTLINE TO-274AA

SYMBOL	DIMENSIONS				NOTES
	MILLIMETERS		INCHES		
	MIN.	MAX.	MIN.	MAX.	
A	4.50	5.50	.177	.217	
A1	1.45	2.15	.057	.085	
A2	1.65	2.35	.065	.093	
b	1.45	1.60	.054	.063	
b1	1.40	1.50	.055	.059	2
b2	2.00	2.40	.079	.094	
b3	1.95	2.35	.077	.093	2
b4	3.00	3.15	.118	.124	
b5	2.95	3.35	.116	.132	2
c	1.10	1.30	.043	.051	
c1	0.90	1.10	.035	.043	2
c2	0.65	0.85	.026	.033	
c3	0.50	0.70	.020	.028	2
D	19.80	20.80	.780	.819	3
D1	15.50	16.10	.610	.634	
D2	0.70	1.30	.028	.051	
D3	0.75	1.25	.030	.049	
E	15.10	16.10	.594	.634	
E1	13.30	13.90	.524	.547	
E2	2.25	2.70	.089	.109	
E3	1.20	1.70	.047	.067	
E4	2.00	3.00	.079	.118	
e	5.45 BSC		.215 BSC		
L	13.80	14.80	.535	.583	
L1	1.00	1.60	.039	.063	
L2	3.85	4.25	.152	.167	
R	2.00	3.00	.079	.118	

LEAD ASSIGNMENTS

MOSEFET

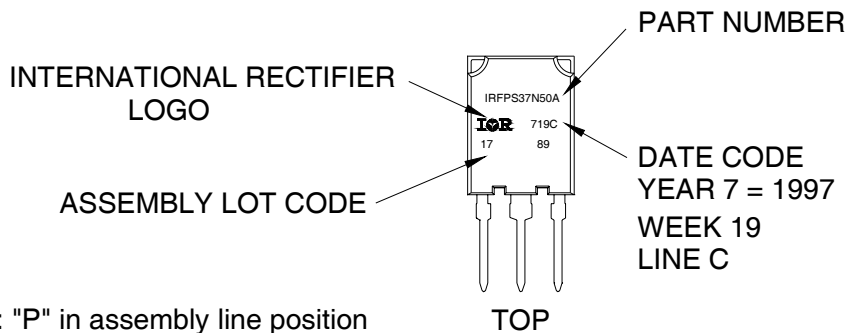
- 1.- GATE
- 2.- DRAIN
- 3.- SOURCE
- 4.- DRAIN

IGBT

- 1.- GATE
- 2.- COLLECTOR
- 3.- EMITTER
- 4.- COLLECTOR

Super-247 (TO-274AA) Part Marking Information

EXAMPLE: THIS IS AN IRFPS37N50A WITH
ASSEMBLY LOT CODE 1789
ASSEMBLED ON WW 19, 1997
IN THE ASSEMBLY LINE "C"



Note: "P" in assembly line position indicates "Lead-Free"

Super-247 package is not recommended for Surface Mount Application.

Note: For the most current drawing please refer to IR website at <http://www.irf.com/package/>

Data and specifications subject to change without notice.
This product has been designed and qualified for Industrial market.
Qualification Standards can be found on IR's Web site.